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74HC4020; 74HCT4020 14-stage binary ripple counter Rev. 5 – 6 August 2012

General description 1.

The 74HC4020; 74HCT4020 are high-speed Si-gate CMOS devices and are pin compatible with the HEF4020B series. They are specified in compliance with JEDEC standard no. 7A.

The 74HC4020; 74HCT4020 are 14-stage binary ripple counters with a clock input (CP), an overriding asynchronous master reset input (MR) and twelve parallel outputs (Q0, Q3 to Q13). The counter advances on the HIGH-to-LOW transition of CP.

A HIGH on MR clears all counter stages and forces all outputs LOW, independent of the state of \overline{CP} .

Each counter stage is a static toggle flip-flop.

2. **Features and benefits**

- Multiple package options
- Complies with JEDEC standard no. 7A
- Specified from –40 °C to +85 °C and from –40 °C to +125 °C

3. **Applications**

- Frequency dividing circuits
- Time delay circuits
- **Control counters**

Ordering information 4.

Table 1. **Ordering information**

Type number	Package									
	Temperature range	Name	Description	Version						
74HC4020N	–40 °C to +125 °C	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4						
74HCT4020N										
74HC4020D	–40 °C to +125 °C	SO16	plastic small outline package; 16 leads;	SOT109-1						
74HCT4020D			body width 3.9 mm							
74HC4020DB	–40 °C to +125 °C	SSOP16								
74HCT4020DB			width 5.3 mm							

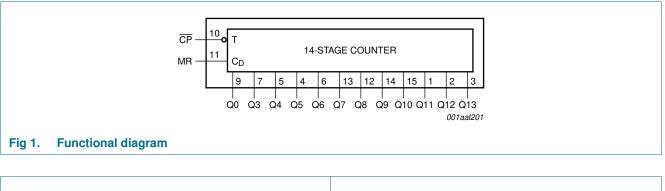


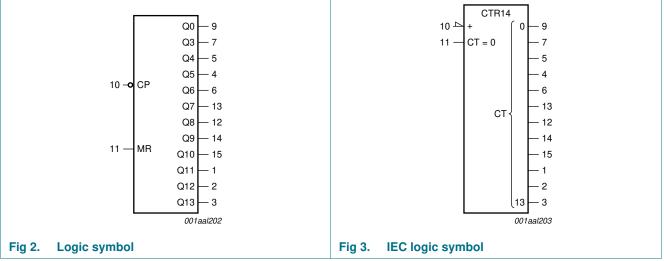
14-stage binary ripple counter

Type number	Package								
	Temperature range	Name	Description	Version					
74HC4020PW 74HCT4020PW	–40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1					
74HC4020BQ 74HCT4020BQ	–40 °C to +125 °C	DHVQFN16	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body $2.5 \times 3.5 \times 0.85$ mm	SOT763-1					

Table 1. Ordering information ...continued

5. Functional diagram

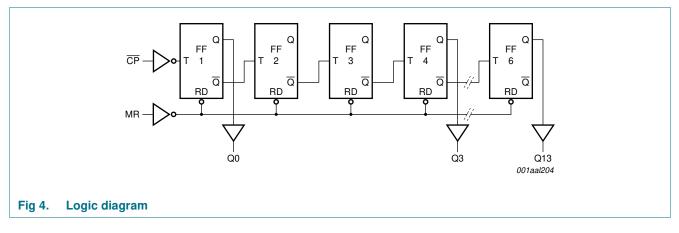




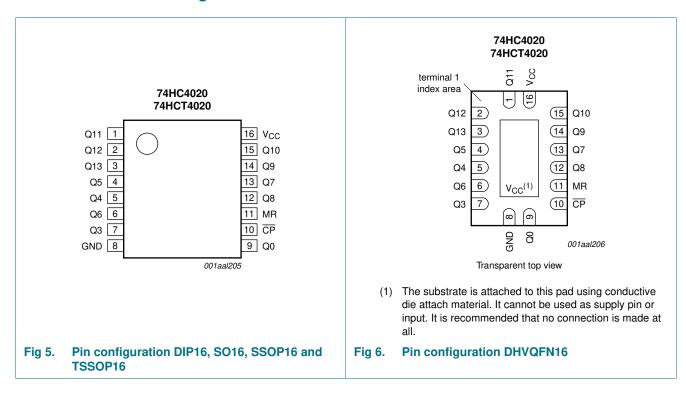
NXP Semiconductors

74HC4020; 74HCT4020

14-stage binary ripple counter



6. Pinning information



6.1 Pinning

6.2 Pin description

Table 2. Pin des	cription			
Symbol	Pin	Description		
Q0, Q3 to Q13	9, 7, 5, 4, 6, 13, 12, 14, 15, 1, 2, 3	output		
GND	8	ground (0 V)		
CP	10	clock input (HIGH-to-LOW, edge-triggered)		
MR	11	master reset input (active HIGH)		
V _{CC}	16	positive supply voltage		
74HC_HCT4020	C_HCT4020 All information provided in this document is subject to legal disclaimers.			
Product data sheet	Rev. 5 — 6 Au	ugust 2012 3 of 20		

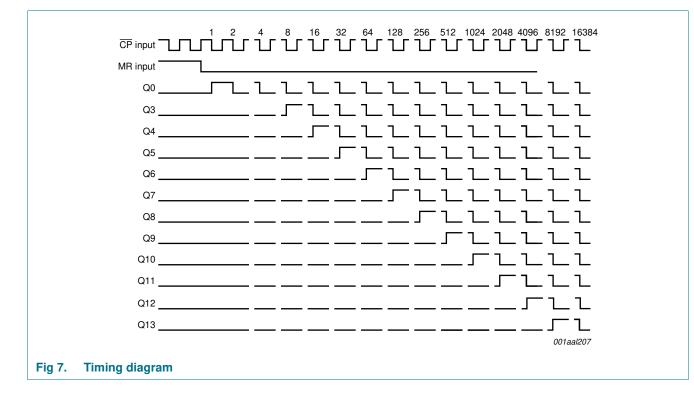
14-stage binary ripple counter

7. Functional description

Table 3.	Function table		
Input CP			Output
СР		MR	Q0, Q3 to Q13
\uparrow		L	no change
\downarrow		L	count
Х		Н	L

[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; $\uparrow = LOW$ -to-HIGH clock transition; $\downarrow = HIGH$ -to-LOW clock transition.

7.1 Timing diagram



14-stage binary ripple counter

8. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7	V
I _{IK}	input clamping current	$V_{\rm I} < -0.5$ V or $V_{\rm I} > V_{\rm CC}$ + 0.5 V	-	±20	mA
l _{ок}	output clamping current	$V_{\rm I} < -0.5$ V or $V_{\rm I} > V_{\rm CC}$ + 0.5 V	-	±20	mA
lo	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	-	±25	mA
I _{CC}	supply current		-	±50	mA
I _{GND}	ground current		-	±50	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 \ ^{\circ}C \ to \ +125 \ ^{\circ}C$	[1]		
	DIP16 package		-	750	mW
	SO16, SSOP16, TSSOP16 and DHVQFN16 packages		-	500	mW

For DIP16 package: Ptot derates linearly with 12 mW/K above 70 °C.
 For SO16 package: Ptot derates linearly with 8 mW/K above 70 °C.
 For SSOP16 and TSSOP16 packages: Ptot derates linearly with 5.5 mW/K above 60 °C.
 For DHVQFN16 package: Ptot derates linearly with 4.5 mW/K above 60 °C.

9. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	7	4HC402	20	74	HCT40	20	Unit
			Min	Тур	Max	Min	Тур	Max	
V _{CC}	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V
VI	input voltage		0	-	V_{CC}	0	-	V_{CC}	V
Vo	output voltage		0	-	V_{CC}	0	-	V_{CC}	V
$\Delta t / \Delta V$	input transition rise and fall rate	except for Schmitt trigger inputs							
		$V_{CC} = 2.0 V$	-	-	625	-	-	-	ns/V
		$V_{CC} = 4.5 V$	-	1.67	139	-	1.67	139	ns/V
		$V_{\rm CC} = 6.0 \ V$	-	-	83	-	-	-	ns/V
T _{amb}	ambient temperature		-40	+25	+125	-40	+25	+125	°C

14-stage binary ripple counter

10. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		–40 °C t	o +85 °C	–40 °C to	o +125 ℃	Uni
			Min	Тур	Max	Min	Max	Min	Max	
74HC40	20						1			
V _{IH}	HIGH-level	$V_{CC} = 2.0 V$	1.5	1.2	-	1.5	-	1.5	-	V
	input voltage	$V_{CC} = 4.5 V$	3.15	2.4	-	3.15	-	3.15	-	V
		$V_{CC} = 6.0 V$	4.2	3.2	-	4.2	-	4.2	-	V
V _{IL}	LOW-level	$V_{CC} = 2.0 V$	-	0.8	0.5	-	0.5	-	0.5	V
	input voltage	$V_{CC} = 4.5 V$	-	2.1	1.35	-	1.35	-	1.35	V
		$V_{CC} = 6.0 V$	-	2.8	1.8	-	1.8	-	1.8	V
V _{OH}	HIGH-level	$V_{I} = V_{IH} \text{ or } V_{IL}$								
	output voltage	$I_O = -20 \ \mu\text{A}; \ V_{CC} = 2.0 \ \text{V}$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_O = -20 \ \mu\text{A}; \ V_{CC} = 4.5 \ \text{V}$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_O = -20 \ \mu A; \ V_{CC} = 6.0 \ V$	5.9	6.0	-	5.9	-	5.9	-	V
		$I_{O} = -4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.98	4.32	-	3.84	-	3.7	-	V
		$I_{O} = -5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.48	5.81	-	5.34	-	5.2	-	۷
V _{OL}	LOW-level	$V_I = V_{IH} \text{ or } V_{IL}$								
	output voltage	$I_{O} = 20 \ \mu A; V_{CC} = 2.0 \ V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O=20~\mu\text{A};V_{CC}=4.5~\text{V}$	-	0	0.1	-	0.1	-	0.1	V
		$I_{O} = 20 \ \mu A; V_{CC} = 6.0 \ V$	-	0	0.1	-	0.1	-	0.1	۷
		I_{O} = 4.0 mA; V_{CC} = 4.5 V	-	0.15	0.26	-	0.33	-	0.4	۷
		$I_{O} = 5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.16	0.26	-	0.33	-	0.4	V
I	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 V$	-	-	±0.1	-	±1	-	±1	μA
сс	supply current	$\label{eq:VI} \begin{array}{l} V_{I} = V_{CC} \text{ or GND}; \ I_{O} = 0 \ \text{A}; \\ V_{CC} = 6.0 \ \text{V} \end{array}$	-	-	8.0	-	80	-	160	μA
CI	input capacitance		-	3.5	-	-	-	-	-	pF
74HCT4	020									
V _{IH}	HIGH-level input voltage	V_{CC} = 4.5 V to 5.5 V	2.0	1.6	-	2.0	-	2.0	-	V
V _{IL}	LOW-level input voltage	V_{CC} = 4.5 V to 5.5 V	-	1.2	0.8	-	0.8	-	0.8	V
V _{OH}	HIGH-level	$V_{I} = V_{IH} \text{ or } V_{IL}; V_{CC} = 4.5 \text{ V}$								
	output voltage	I _O = -20 μA	4.4	4.5	-	4.4	-	4.4	-	۷
		$I_{\rm O} = -4.0 \text{ mA}$	3.98	4.32	-	3.84	-	3.7	-	۷
V _{OL}	LOW-level	$V_{I} = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 V$								
	output voltage	$I_{O} = 20 \ \mu A; V_{CC} = 4.5 \ V$	-	0	0.1	-	0.1	-	0.1	۷
		$I_{O} = 4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	0.15	0.26	-	0.33	-	0.4	V
I	input leakage current	$V_{I} = V_{CC} \text{ or GND};$ $V_{CC} = 5.5 \text{ V}$	-	-	±0.1	-	±1	-	±1	μA

14-stage binary ripple counter

Table 6. Static characteristics ... continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		–40 °C to	• +85 °C	–40 °C to	+125 °C	Unit
			Min	Тур	Max	Min	Мах	Min	Max	
I _{CC}	supply current		-	-	8.0	-	80	-	160	μA
ΔI_{CC}	additional supply current	$\label{eq:VI} \begin{array}{l} V_{I} = V_{CC} - 2.1 \ \text{V}; \ I_{O} = 0 \ \text{A}; \\ \text{other inputs at } V_{CC} \ \text{or GND}; \\ V_{CC} = 4.5 \ \text{V} \ \text{to} \ 5.5 \ \text{V} \end{array}$								
		pin MR	-	110	396	-	495	-	539	μA
		pin CP	-	85	306	-	383	-	417	μA
CI	input capacitance		-	3.5	-	-	-	-	-	pF

11. Dynamic characteristics

Table 7. Dynamic characteristics

GND (ground = 0 V); C_L = 50 pF unless otherwise specified; for test circuit, see <u>Figure 10</u>

Symbol	Parameter	Conditions		25 °C	;	–40 °C t	o +85 °C	-40 °C to	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC402	20		•	•	•					
t _{pd}	propagation	CP to Q0; see Figure 8 [1]								
	delay	$V_{CC} = 2.0 \text{ V}; C_{L} = 50 \text{ pF}$	-	39	140	-	175	-	210	ns
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$	-	14	28	-	35	-	42	ns
		$V_{CC} = 5.0 \text{ V}; C_{L} = 15 \text{ pF}$	-	11	-	-	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}; C_L = 50 \text{ pF}$	-	11	24	-	30	-	36	ns
		Qn to Qn+1; see Figure 9								
		$V_{CC} = 2.0 \text{ V}; C_L = 50 \text{ pF}$	-	22	75	-	95	-	110	ns
		$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$	-	8	15	-	19	-	22	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	6	-	-	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	-	6	13	-	16	-	19	ns
t _{PHL}	HIGH to LOW	MR to Qn; see Figure 8								
	propagation delay	V_{CC} =2.0 V; C_{L} = 50 pF	-	55	170	-	215	-	225	ns
	delay	$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$	-	20	34	-	43	-	51	ns
		$V_{CC} = 5.0 \text{ V}; C_{L} = 15 \text{ pF}$	-	17	-	-	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}; C_{L} = 50 \text{ pF}$	-	16	29	-	37	-	43	ns
tt	transition	Qn; see Figure 8 [2]								
	time	$V_{CC} = 2.0 \text{ V}; C_{L} = 50 \text{ pF}$	-	19	75	-	95	-	110	ns
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$	-	7	15	-	19	-	22	ns
		$V_{CC} = 6.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	-	6	13	-	16	-	19	ns

14-stage binary ripple counter

Symbol	Parameter	Conditions			25 °C		–40 °C t	o +85 °C	-40 °C to	o +125 °C	Uni
				Min	Тур	Max	Min	Max	Min	Max	
tw	pulse width	CP HIGH or LOW; see Figure 8									
		$V_{CC} = 2.0 \text{ V}; C_{L} = 50 \text{ pF}$		80	14	-	100	-	120	-	ns
		V _{CC} = 4.5 V; C _L = 50 pF		16	4	-	20	-	24	-	ns
		V _{CC} = 6.0 V; C _L = 50 pF		14	3	-	17	-	20	-	ns
		MR HIGH; see Figure 8									
		$V_{CC} = 2.0 \text{ V}; C_{L} = 50 \text{ pF}$		80	17	-	100	-	120	-	ns
		V _{CC} = 4.5 V; C _L = 50 pF		16	6	-	20	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$		14	5	-	17	-	20	-	ns
t _{rec}	recovery time	MR to CP; see Figure 8									
		$V_{CC} = 2.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$		50	6	-	65	-	75	-	ns
		V _{CC} = 4.5 V; C _L = 50 pF		10	2	-	13	-	15	-	ns
		$V_{CC} = 6.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$		9	2	-	11	-	13	-	ns
f _{max}	maximum	see Figure 8									
	frequency	$V_{CC} = 2.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$		6.0	30	-	4.8	-	4.0	-	MH
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$		30	92	-	24	-	20	-	MH
		V _{CC} = 5.0 V; C _L = 15 pF		-	101	-	-	-	-	-	MH
		$V_{CC} = 6.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$		35	109	-	28	-	24	-	MH
C _{PD}	power dissipation capacitance		<u>[3]</u>	-	19	-	-	-	-	-	pF
74HCT40)20										
t _{pd}	propagation	CP to Q0; see Figure 8	[1]								
	delay	$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$		-	18	36	-	45	-	54	ns
		V _{CC} = 5.0 V; C _L = 15 pF		-	15	-	-	-	-	-	ns
		Qn to Qn+1; see Figure 9									
		V _{CC} = 4.5 V; C _L = 50 pF		-	8	15	-	19	-	22	ns
		V _{CC} = 5.0 V; C _L = 15 pF		-	6	-	-	-	-	-	ns
t _{PHL}	HIGH to LOW	MR to Qn; see Figure 8									
	propagation	$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$		-	22	45	-	56	-	68	ns
	delay	V _{CC} = 5.0 V; C _L = 15 pF		-	19	-	-	-	-	-	ns
tt	transition	Qn; see Figure 8	[2]								
	time	$V_{CC} = 4.5 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$		-	7	15	-	19	-	22	ns
tw	pulse width	CP HIGH or LOW; see Figure 8									
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$		20	7	-	25	-	30	-	ns
		MR HIGH; see Figure 8									
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$		20	8	-	25	-	30	-	ns
t _{rec}	recovery time	MR to CP; see Figure 8									
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$		10	2	-	13	-	15	-	ns

Table 7. Dynamic characteristics ... continued

GND (around = 0 V): $C_1 = 50 \text{ pF}$ unless otherwise specified: for test circuit, see Figure 10

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14-stage binary ripple counter

Symbol	Parameter	Conditions		25 °C		–40 °C t	o +85 °C	–40 °C to	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
f _{max}	maximum	see Figure 8								
	frequency	$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$	25	47	-	20	-	17	-	MHz
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$	-	52	-	-	-	-	-	MHz
C _{PD}	power dissipation capacitance	[3]	-	20	-	-	-	-	-	pF

Table 7. Dynamic characteristics ...continued

GND (ground = 0 V); C_L = 50 pF unless otherwise specified; for test circuit, see Figure 10

[1] t_{pd} is the same as t_{PHL} and t_{PLH} .

[2] t_t is the same as t_{THL} and t_{TLH} .

[3] C_{PD} is used to determine the dynamic power dissipation (P_D in μ W).

 $P_{D} = C_{PD} \times V_{CC}^{2} \times f_{i} + \Sigma \ (C_{L} \times V_{CC}^{2} \times f_{o}) \text{ where:}$

 f_i = input frequency in MHz;

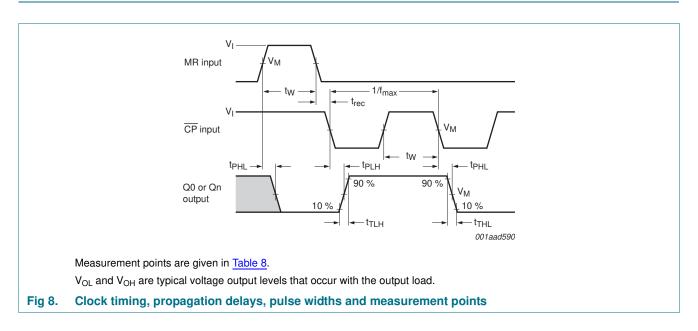
 $f_o = output frequency in MHz;$

 $\Sigma (C_L \times V_{CC}^2 \times f_o) = sum of outputs;$

 C_L = output load capacitance in pF;

 V_{CC} = supply voltage in V.

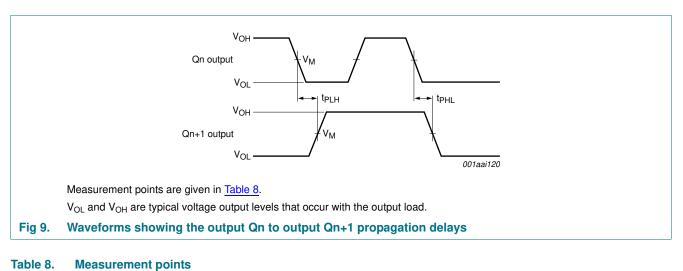
12. Waveforms



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74HC4020; 74HCT4020

14-stage binary ripple counter



Туре	Input	Output
	V _M	V _M
74HC4020	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$
74HCT4020	1.3 V	1.3 V

NXP Semiconductors

74HC4020; 74HCT4020

14-stage binary ripple counter

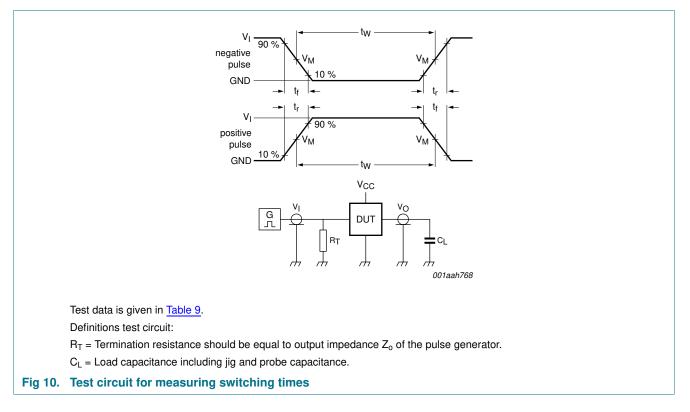


Table 9. Test data

Туре	Input		Load
	VI	t _r , t _f	CL
74HC4020	V _{CC}	6 ns	15 pF, 50 pF
74HCT4020	3 V	6 ns	15 pF, 50 pF

14-stage binary ripple counter

13. Package outline

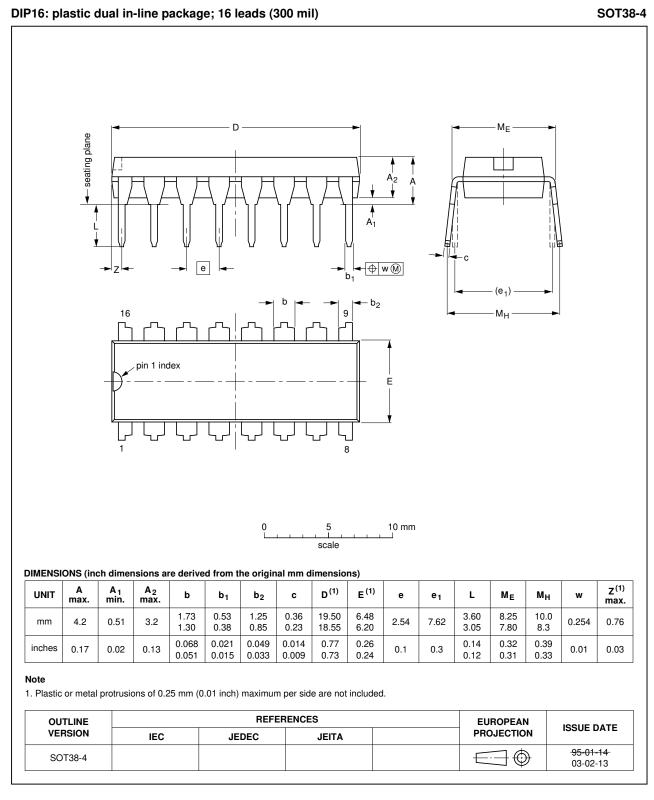


Fig 11. Package outline SOT38-4 (DIP16)

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74HC HCT4020

14-stage binary ripple counter

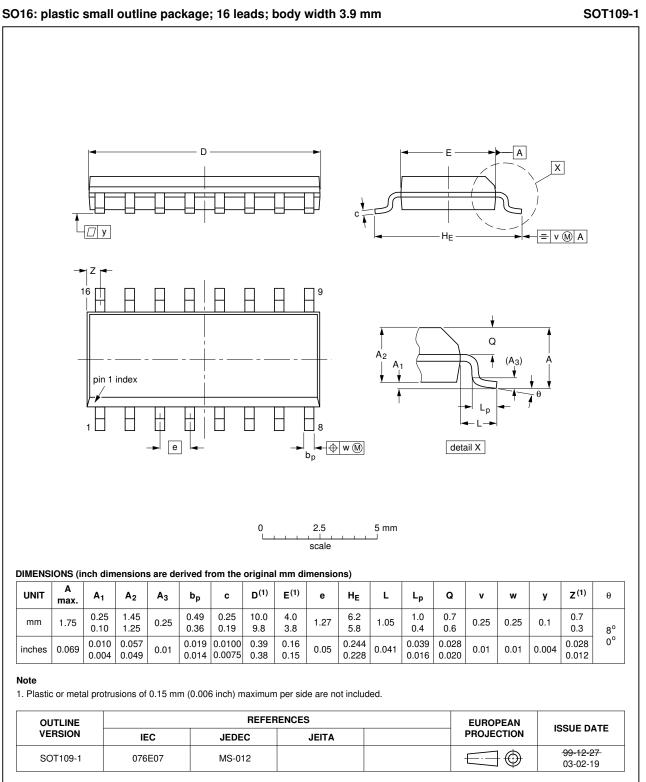


Fig 12. Package outline SOT109-1 (SO16)

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14-stage binary ripple counter

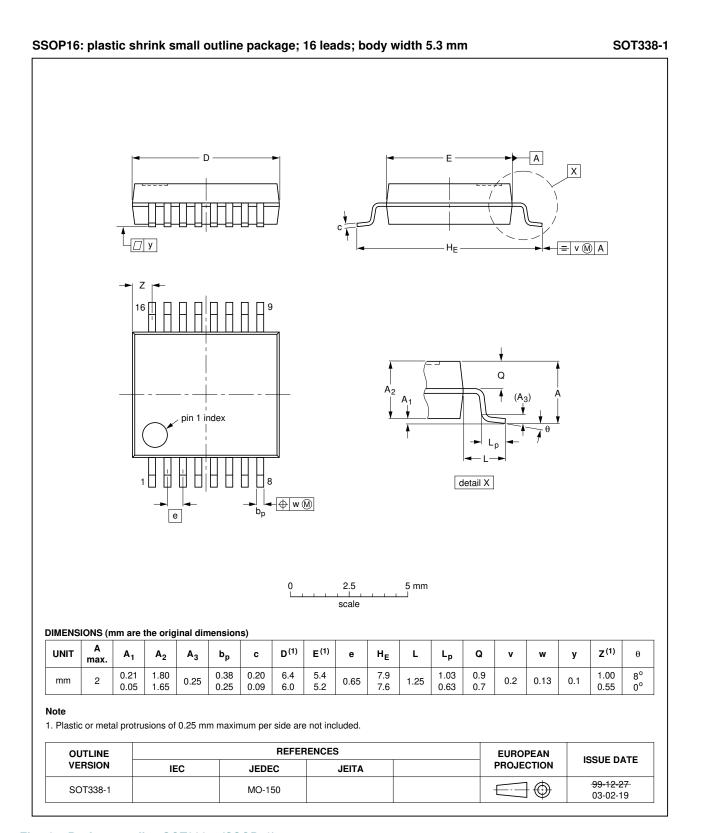


Fig 13. Package outline SOT338-1 (SSOP16)

14-stage binary ripple counter

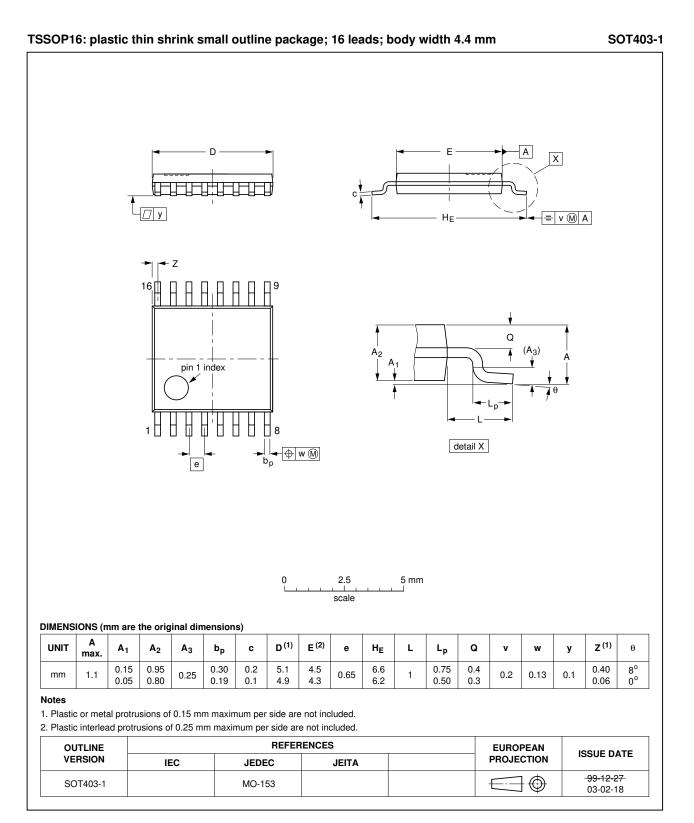
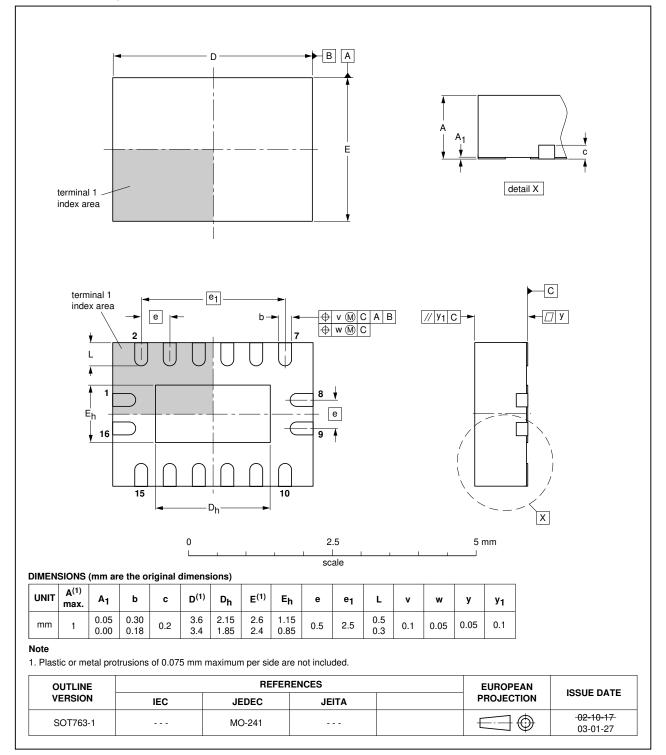


Fig 14. Package outline SOT403-1 (TSSOP16)

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14-stage binary ripple counter



DHVQFN16: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm SOT763-1

Fig 15. Package outline SOT763-1 (DHVQFN16)

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74HC HCT4020



14. Abbreviations

Table 10. Abbre	viations
Acronym	Abbreviation
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test

15. Revision history

Table 11.Revision history

	•			
Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT4020 v.5	20120806	Product data sheet	-	74HC_HCT4020 v.4
Modifications:	 Measurement point 	ts added to figure 8 (errat	a).	
74HC_HCT4020 v.4	20111213	Product data sheet	-	74HC_HCT4020 v.3
Modifications:	 Legal pages update 	ed.		
74HC_HCT4020 v.3	20100120	Product data sheet	-	74HC_HCT4020_CNV v.2
74HC_HCT4020_CNV v.2	19970901	Product specification	-	-

16. Legal information

16.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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